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|-----------------------------------|---------------------------------------|-------------------------------------------------------------|-------------|
| Notice of References Cited | Application/Control No. 09/917,483 | Applicant(s)/Patent Under Reexamination BRAVEK ET AL. | |
| | Examiner Lynne Edmondson | Art Unit 1725 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--------------------------------------------------|-----------------|----------------------|----------------|
| * | A | US-4,217,024 | 08-1980 | Aldridge et al. | 439/381 |
| * | B | US-RE36,442 | 12-1999 | Kardos, Gabor | 324/758 |
| * | C | US-4,912,603 | 03-1990 | Seyama, Kiyotaka | 361/777 |
| * | D | US-5,784,262 | 07-1998 | Sherman, John V. | 361/777 |
| * | E | US-2003/0054589 A1 | 03-2003 | Matsuda et al. | 438/108 |
| * | F | US-4,734,818 | 03-1988 | Hernandez et al. | 174/52.4 |
| * | G | US-3,610,811 | 10-1971 | O'Keefe, James E. | 174/262 |
| * | H | US-4,296,993 | 10-1981 | Wellington, Roger D. | 439/876 |
| * | I | US-5,736,680 | 04-1998 | Caldwell et al. | 174/250 |
| * | J | US-5,450,290 | 09-1995 | Boyko et al. | 361/792 |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--------------------------------------------------|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
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NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|-------------------------------------------------------------------------------------------|
| | U | |
| | V | |
| | W | |
| | X | |

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